

Description

The AP2312MI uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a

Battery protection or in other Switching application.

General Features

 $V_{DS} = 20V I_{D} = 6.8A$

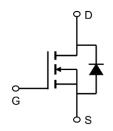
 $R_{DS(ON)}$ < 18m Ω @ V_{GS} =4.5V

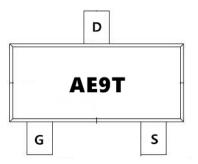
Application

Lithium battery protection

Wireless impact

Mobile phone fast charging







Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP2312MI	SOT-23-3L	AE9T	3000

Absolute Maximum Ratings (T_C=25°Cunless otherwise noted)

Symbol Parameter		Rating	Units	
V _D S	Drain-Source Voltage 20		V	
Vgs	Gate-Source Voltage	±12	V	
I _D @T _A =25°C	Continuous Drain Current	6.8	А	
I _D @T _A =70°C	Continuous Drain Current	6.0	А	
Ірм	Pulsed Drain Current ²	30	A	
P _D @T _A =25°C	Total Power Dissipation ³	1.5	W	
Тѕтс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	5 to 150 °C	
Reja	Thermal Resistance Junction-ambient ¹	83 °C/W		



Electrical Characteristics (T_c=25°Cunless otherwise noted)

Symbol	Parameter Conditions		Min	Тур	Max	Units
BVDSS	Drain-Source Breakdown Voltage)rain-Source Breakdown Voltage V _{GS} =0V, I _D =250μA		22		V
VGS(th)	Gate Threshold Voltage V _{DS} = V _{GS} , I _D =250μA		0.50	0.65	1.0	V
RDS(ON)	Static Drain-Source On-Resistance V _{GS} =4.5V, I _D =7.6A			12	18	
RDS(ON)	Static Drain-Source On-Resistance	Static Drain-Source On-Resistance V _{GS} =2.5V, I _D =3.5A		15.5	20	mΩ
RDS(ON)	Static Drain-Source On-Resistance	V _{GS} =1.8V, I _D =2.5A		20.5	35	
IDSS	Zero Gate Voltage Drain Current	V _{DS} =20V,V _{GS} =0V			1	μA
IGSS	Gate-Body Leakage Current	V _{GS} =±12V, V _{DS} =0V			±100	nA
Ciss	Input Capacitance			888		
Coss	Output Capacitance V _{DS} =10V,V _{GS} =0V,f=1MHZ			133		pF
Crss	Reverse Transfer Capacitance			117		
Qg	Total Gate Charge			11.05		
Q _{gs}	Gate-Source Charge	V _{GS} =4.5V,V _{DS} =10V,I _D =6.8A		1.73		nC
Q _{gd}	Gate-Drain Charge			3.1		
tD(on)	Turn-on Delay Time			7		
t _r	Turn-on Rise Time V _{GS} =4.5V, V _{DS} =10V, I _D =6.8A			46		ns
tD(off)	Turn-off Delay Time	R _{GEN} =3Ω		30]
t _f	Turn-off fall Time			52		
V _{SD}	Diode Forward Voltage	I _S =7.6A,V _{GS} =0V			1.2	V

Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2. The data tested by pulsed , pulse width $\, \leqq \,$ 300us , duty cycle $\, \leqq \,$ 2%
- $3 {\,{}_{\sim}}\,$ The power dissipation is limited by $150 {\,{}^{\circ}\!{}_{\sim}}\,$ junction temperature
- 4. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation



Typical Characteristics

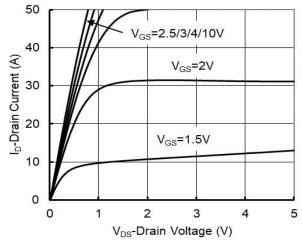


Figure 1. Output Characteristics

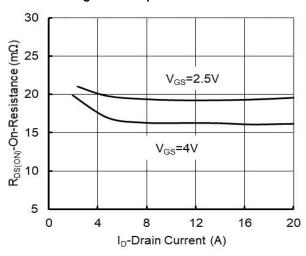


Figure 3: On-Resistance vs. Drain Current

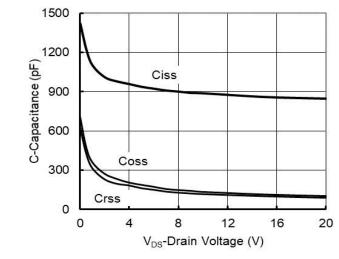


Figure 5. Capacitance Characteristics

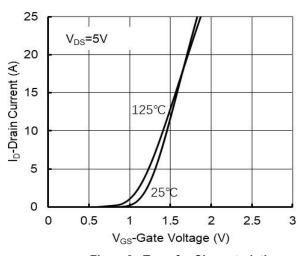


Figure 2. Transfer Characteristics

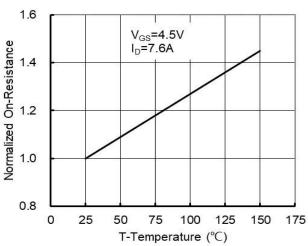


Figure 4: On-Resistance vs. Junction Temperature and Gate Voltage

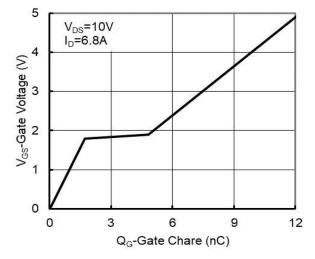
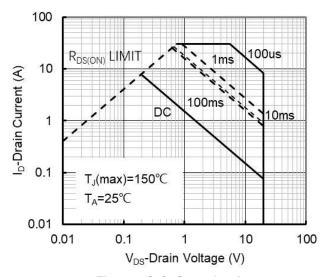


Figure 6. Gate Charge





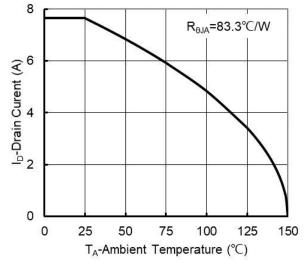


Figure 7. Safe Operation Area

Figure8. Maximum Continuous Drain Current vs Ambient Temperature

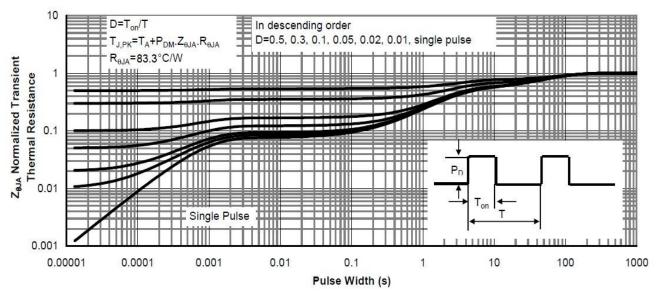
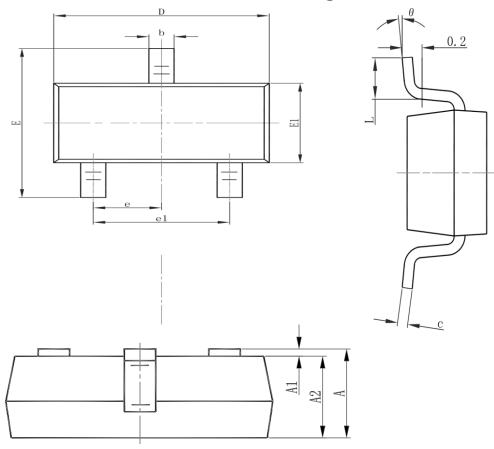


Figure 9. Normalized Maximum Transient Thermal Impedance



Package Mechanical Data-SOT-23-3L-Single



	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E1	1.500	1.700	0.059	0.067	
E	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.037(BSC)		
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	



20V N-Channel Enhancement Mode MOSFET Attention

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Edition	Date	Change
Rve3.8	2018/1/31	Initial release
Rve3.9	2020/8/01	Reduce RDS(on)

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